

COMPLIANT

### FQP4N90-VB Datasheet

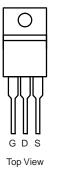
## N-Channel 900V (D-S) Super Junction Power MOSFET

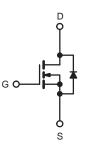
PRODUCT SUMMARY				
V <sub>DS</sub> (V)	900			
R <sub>DS(on)</sub> (Ω)	V <sub>GS</sub> = 10 V 1.3			
Q <sub>g</sub> (Max.) (nC)	200			
Q <sub>gs</sub> (nC)	24			
Q <sub>gd</sub> (nC)	110			
Configuration	Sing	le		

### **FEATURES**

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Isolated Central Mounting Hole
- · Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC







N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T <sub>C</sub>	= 25 °C, unl	ess otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V <sub>DS</sub>	900	V	
Gate-Source Voltage			V <sub>GS</sub>	± 20	v	
Continuous Drain Current	V <sub>GS</sub> at 10 V	$T_{C} = 25 \text{ °C}$ $T_{C} = 100 \text{ °C}$	I <sub>D</sub>	5 3.9	А	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	21	_	
Linear Derating Factor				1.5	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	770	mJ	
Repetitive Avalanche Current <sup>a</sup>			I <sub>AR</sub>	7.8	А	
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	19	mJ	
Maximum Power Dissipation $T_{C} = 25 \text{ °C}$			PD	190	W	
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	2.0	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	ാം	
Soldering Recommendations (Peak Temperature) for 10 s				300 <sup>d</sup>		
Mounting Torquo	6-32 or M3 screw			10	lbf ∙ in	
Mounting Torque				1.1	N · m	

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b.  $V_{DD} = 50$  V, starting  $T_J = 25$  °C, L = 23 mH,  $R_g = 25 \Omega$ ,  $I_{AS} = 7.8$  A (see fig. 12). c.  $I_{SD} \le 7.8$  A, dl/dt  $\le 140$  A/µs,  $V_{DD} \le 600$  V,  $T_J \le 150$  °C. d. 1.6 mm from case.

\* Pb containing terminations are not RoHS compliant, exemptions may apply

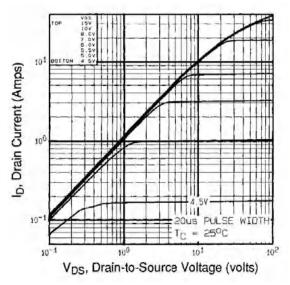


THERMAL RESISTANCE RATI	NGS							
PARAMETER	SYMBOL	TYP.		MAX.			UNIT	
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-		40				
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	0.24		-			°C/W	
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-		0.65				
<b>SPECIFICATIONS</b> (T <sub>J</sub> = 25 °C, u	nless otherwi	se noted)						
PARAMETER	SYMBOL	1	T CONDIT	IONS	MIN.	TYP.	MAX.	UNIT
Static		1				•	•	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> :	= 0 V, I <sub>D</sub> =	250 µA	900	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C,	I <sub>D</sub> = 1 mA	-	0.98	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	= V <sub>GS</sub> , I <sub>D</sub> =	250 µA	2.0	-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>		$V_{GS} = \pm 20$		-	-	± 100	nA
		V <sub>DS</sub> =	= 800 V, V <sub>0</sub>	<sub>as</sub> = 0 V	-	-	100	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 640 \	$V, V_{GS} = 0$	√, T <sub>J</sub> = 125 °C	-	-	500	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V		<sub>0</sub> = 3.7 A <sup>b</sup>	-	1.3	-	Ω
Forward Transconductance	<b>g</b> fs	V <sub>DS</sub> =	= 100 V, I <sub>D</sub> =	= 3.7 A <sup>b</sup>	5.6	-	-	S
Dynamic		•						<u> </u>
Input Capacitance	C <sub>iss</sub>		$V_{ee} = 0$	1	-	3100	-	
Output Capacitance	Coss		$V_{GS} = 0 V,$ $V_{DS} = 25 V,$ f = 1.0 MHz, see fig. 5		-	800	-	pF
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1			-	490	-	
Total Gate Charge	Qg				-	-	200	
Gate-Source Charge	Q <sub>gs</sub>	$V_{GS} = 10 \text{ V}$ $I_D = 3.8 \text{ A}, V_{DS} = 400 \text{ V},$ see fig. 6 and 13 <sup>b</sup>		-	-	24	nC	
Gate-Drain Charge	Q <sub>gd</sub>		3661	ig. 0 and 15	-	-	110	1
Turn-On Delay Time	t <sub>d(on)</sub>				-	19	-	
Rise Time	tr	V <sub>DD</sub> = 400 V, I <sub>D</sub> = 3.8 A,		-	38	-	1	
Turn-Off Delay Time	t <sub>d(off)</sub>	$\begin{array}{c c} & & - \\ & & \\ V_{DD} = 400 \text{ V}, \text{ I}_{D} = 3.8 \text{ A}, & - \\ & & \\ R_{g} = 6.2 \ \Omega, \ R_{D} = 52 \ \Omega & - \\ & & \\ & \text{see fig. 10^{b}} & - \end{array}$		120	-	ns		
Fall Time	t <sub>f</sub>			-	39	-	1	
Internal Drain Inductance	L <sub>D</sub>	Between lead 6 mm (0.25") f	from		-	5.0	-	1
Internal Source Inductance	Ls	package and center of die contact - 13		13	-	– nH		
Drain-Source Body Diode Characteristic	s	• 			•	•	•	
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET sym showing the	bol		-	-	5.0	Δ
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>	integral reverse p - n junction diode		-	-	21	A	
Body Diode Voltage	V <sub>SD</sub>	$T_{J} = 25 \ ^{\circ}C, I_{S} = 3.8 \text{ A}, V_{GS} = 0 \text{ V}^{b}$		-	-	1.8	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>	$ T_{J} = 25 \text{ °C, } I_{F} = 3.8 \text{ A,} \\ dl/dt = 100 \text{ A/}\mu\text{s}^{b} $		-	650	980	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	3.8	5.7	μC	
Forward Turn-On Time	t <sub>on</sub>	Intrinsic tu	rn-on time	is negligible (turn	-on is do	minated k	by $L_{S}$ and	L <sub>D</sub> )

#### Notes

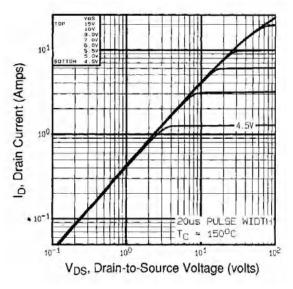
a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
b. Pulse width ≤ 300 µs; duty cycle ≤ 2 %.





### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)







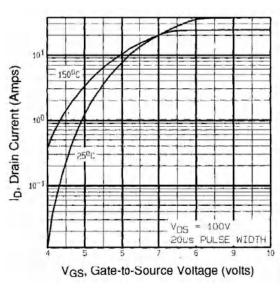
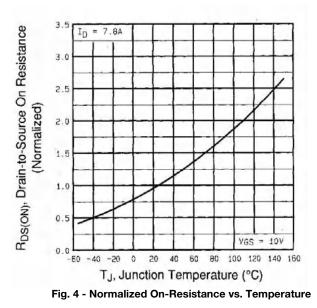


Fig. 3 - Typical Transfer Characteristics



### FQP4N90-VB



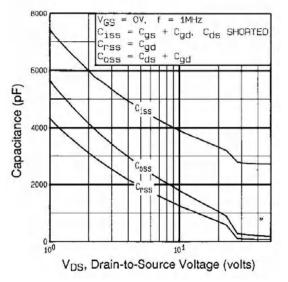


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage



Fig. 7 - Typical Source-Drain Diode Forward Voltage

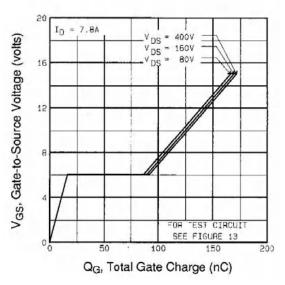
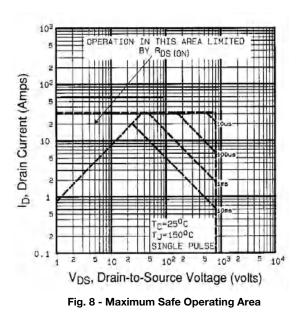


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



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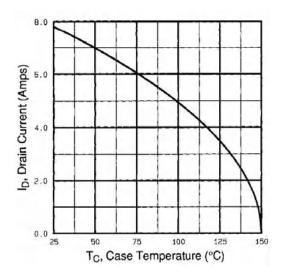


Fig. 9 - Maximum Drain Current vs. Case Temperature

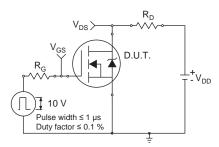


Fig. 10a - Switching Time Test Circuit



Fig. 10b - Switching Time Waveforms

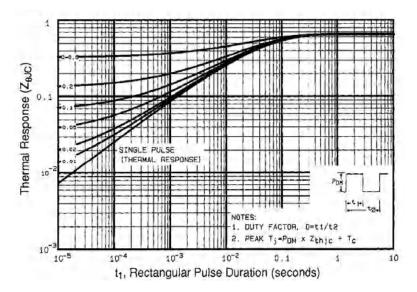


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



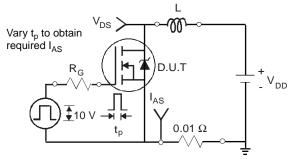


Fig. 12a - Unclamped Inductive Test Circuit

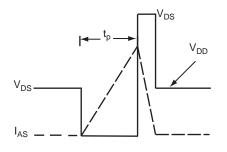


Fig. 12b - Unclamped Inductive Waveforms



Fig. 12c - Maximum Avalanche Energy vs. Drain Current

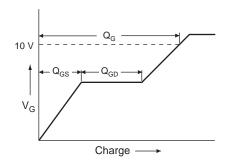


Fig. 13a - Basic Gate Charge Waveform

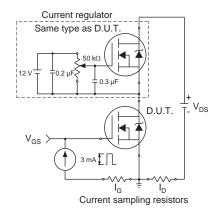
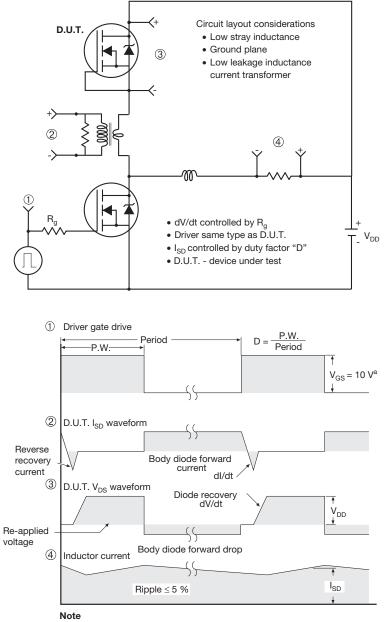


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit

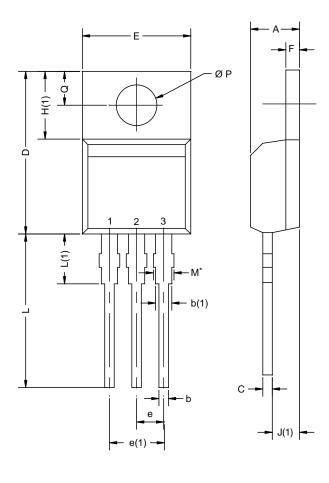


a.  $V_{GS} = 5$  V for logic level devices

Fig. 14 - For N-Channel



# **TO-220AB**



	MILLIN	IETERS	INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
А	4.25	4.65	0.167	0.183
b	0.69	1.01	0.027	0.040
b(1)	1.20	1.73	0.047	0.068
С	0.36	0.61	0.014	0.024
D	14.85	15.49	0.585	0.610
Е	10.04	10.51	0.395	0.414
е	2.41	2.67	0.095	0.105
e(1)	4.88	5.28	0.192	0.208
F	1.14	1.40	0.045	0.055
H(1)	6.09	6.48	0.240	0.255
J(1)	2.41	2.92	0.095	0.115
L	13.35	14.02	0.526	0.552
L(1)	3.32	3.82	0.131	0.150
ØΡ	3.54	3.94	0.139	0.155
Q	2.60	3.00	0.102	0.118
ECN: X12- DWG: 547	0208-Rev. N, 1	08-Oct-12		

#### Notes

 $^{\star}$  M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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